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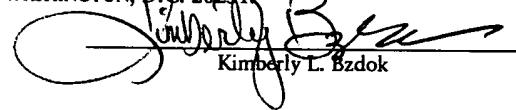
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:	AMIEL FARRINGTON	Examiner:	
Serial No.:	10/088,792	Group Art Unit:	2856
Filed:	March 21, 2002	Docket No.	58323-245158
For:	CHEMICAL SENSING SYSTEM		

Commissioner for Patents
Washington, D.C. 20231

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Kimberly L. Bzdok

INFORMATION DISCLOSURE STATEMENT

The references listed on the enclosed form PTO-1449 are provided for consideration by the Examiner. A copy of each of these references is enclosed.

No fee is believed to be necessary. Should any fee be required, the Commissioner is authorized to charge our Deposit Account No. 06-0029 and notify us of the same.

Respectfully Submitted,

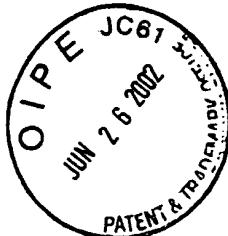
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Dated: June 20, 2002

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Atty. Docket No.	Serial No.
58323-245158	10/088,792
Applicant	
AMIEL FARRINGTON	
Filing Date	Group
March 21, 2002	

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
Name	Document Number	Date	Country	Class	Subclass	Translation Yes/No
	0,567,782	11.03.93	EP			yes
	2,184,037	06.17.87	GB			yes
	97,46755	12.11.97	WO			yes

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Development of a Curie-Point Headspace Sampler for Capillary Gas Chromatography, Oguri N. and Onishi, A., HRC Journal of High Resolution Chromatography, Vol. 14, No. 2, February 1991, pp. 79-82.

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609;
Draw line through citation if not in conformance and not considered. Include copy of this form with
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